Application/Control No. Applicant(s)/Patent Under Reexamination 10/023,564 HOISKO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 David Q Nguyen 2681 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,070,053 A 05-2000 Yamashita, Tomohisa 340/7.58 Α В US-С US-US-D Ε US-F US-G US-Н US-USı US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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